

Preliminary datasheet

EasyDUAL module with CoolSiC™ Trench MOSFET and PressFIT / NTC

Features

- Electrical features
 - $V_{DSS} = 1200 \text{ V}$
 - $I_{DN} = 200 \text{ A} / I_{DRM} = 400 \text{ A}$
 - Low switching losses
 - Low inductive design
 - High current density
- Mechanical features
 - Rugged mounting due to integrated mounting clamps
 - PressFIT contact technology
 - Integrated NTC temperature sensor



Typical appearance

Potential applications

- Solar applications
- High-frequency switching application
- DC/DC converter
- UPS systems

Product validation

- Qualified for industrial applications according to the relevant tests of IEC 60747, 60749 and 60068

Description

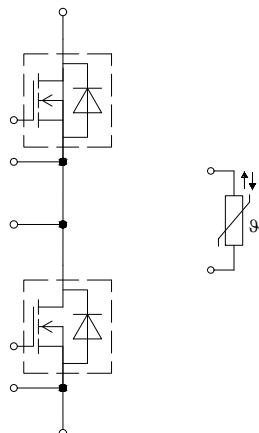


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1 Package

1 Package

Table 1 Insulation coordination

Parameter	Symbol	Note or test condition	Values	Unit
Isolation test voltage	V_{ISOL}	RMS, $f = 50 \text{ Hz}$, $t = 1 \text{ min}$	3.0	kV
Internal isolation		basic insulation (class 1, IEC 61140)	Al_2O_3	
Comparative tracking index	CTI		> 200	
Relative thermal index (electrical)	RTI	housing	140	°C

Table 2 Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Stray inductance module	L_{sCE}			8		nH
Module lead resistance, terminals - chip	$R_{CC'EE'}$	$T_H = 25 \text{ °C}$, per switch		1.4		mΩ
Storage temperature	T_{stg}		-40		125	°C
Mounting force per clamp	F		40		80	N
Weight	G			39		g

Note: The current under continuous operation is limited to 25 A rms per connector pin.

2 MOSFET

Table 3 Maximum rated values

Parameter	Symbol	Note or test condition	Values	Unit
Drain-source voltage	V_{DSS}	$T_{vj} = 25 \text{ °C}$	1200	V
Implemented drain current	I_{DN}		200	A
Continuous DC drain current	I_{DDC}	$T_{vj} = 175 \text{ °C}$, $V_{GS} = 18 \text{ V}$	170	A
Repetitive peak drain current	I_{DRM}	verified by design, t_p limited by T_{vjmax}	400	A
Gate-source voltage, max. transient voltage	V_{GS}	$D < 0.01$	-10/23	V
Gate-source voltage, max. static voltage	V_{GS}		-7/20	V

Table 4 Recommended values

Parameter	Symbol	Note or test condition	Values	Unit
On-state gate voltage	$V_{GS(on)}$		15...18	V

(table continues...)

Table 4 (continued) Recommended values

Parameter	Symbol	Note or test condition	Values	Unit
Off-state gate voltage	$V_{GS(off)}$		-5...0	V

Table 5 Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Drain-source on-resistance	$R_{DS(on)}$	$I_D = 200 \text{ A}$	$V_{GS} = 18 \text{ V}, T_{vj} = 25^\circ\text{C}$		4	mΩ
			$V_{GS} = 18 \text{ V}, T_{vj} = 125^\circ\text{C}$		6.5	
			$V_{GS} = 18 \text{ V}, T_{vj} = 175^\circ\text{C}$		8.7	
			$V_{GS} = 15 \text{ V}, T_{vj} = 25^\circ\text{C}$		4.9	
Gate threshold voltage	$V_{GS(th)}$	$I_D = 80 \text{ mA}, V_{DS} = V_{GS}, T_{vj} = 25^\circ\text{C}$, (tested after 1ms pulse at $V_{GS} = +20 \text{ V}$)	3.45	4.3	5.15	V
Total gate charge	Q_G	$V_{DD} = 800 \text{ V}, V_{GS} = -3/18 \text{ V}$		0.594		μC
Internal gate resistor	R_{Gint}	$T_{vj} = 25^\circ\text{C}$		1		Ω
Input capacitance	C_{ISS}	$f = 100 \text{ kHz}, V_{DS} = 800 \text{ V}, V_{GS} = 0 \text{ V}$	$T_{vj} = 25^\circ\text{C}$	17.6		nF
Output capacitance	C_{OSS}	$f = 100 \text{ kHz}, V_{DS} = 800 \text{ V}, V_{GS} = 0 \text{ V}$	$T_{vj} = 25^\circ\text{C}$	0.84		nF
Reverse transfer capacitance	C_{rss}	$f = 100 \text{ kHz}, V_{DS} = 800 \text{ V}, V_{GS} = 0 \text{ V}$	$T_{vj} = 25^\circ\text{C}$	0.056		nF
C_{OSS} stored energy	E_{OSS}	$V_{DS} = 800 \text{ V}, V_{GS} = -3/18 \text{ V}, T_{vj} = 25^\circ\text{C}$		344		μJ
Drain-source leakage current	I_{DSS}	$V_{DS} = 1200 \text{ V}, V_{GS} = -3 \text{ V}$	$T_{vj} = 25^\circ\text{C}$	0.12	660	μA
Gate-source leakage current	I_{GSS}	$V_{DS} = 0 \text{ V}, T_{vj} = 25^\circ\text{C}$	$V_{GS} = 20 \text{ V}$		400	nA
Turn-on delay time (inductive load)	$t_{d\ on}$	$I_D = 200 \text{ A}, R_{Gon} = 2.7 \Omega, V_{DD} = 600 \text{ V}, V_{GS} = -3/18 \text{ V}$	$T_{vj} = 25^\circ\text{C}$	45		ns
			$T_{vj} = 125^\circ\text{C}$	42		
			$T_{vj} = 175^\circ\text{C}$	42		
Rise time (inductive load)	t_r	$I_D = 200 \text{ A}, R_{Gon} = 2.7 \Omega, V_{DD} = 600 \text{ V}, V_{GS} = -3/18 \text{ V}$	$T_{vj} = 25^\circ\text{C}$	44		ns
			$T_{vj} = 125^\circ\text{C}$	41		
			$T_{vj} = 175^\circ\text{C}$	41		
Turn-off delay time (inductive load)	$t_{d\ off}$	$I_D = 200 \text{ A}, R_{Goff} = 1 \Omega, V_{DD} = 600 \text{ V}, V_{GS} = -3/18 \text{ V}$	$T_{vj} = 25^\circ\text{C}$	74		ns
			$T_{vj} = 125^\circ\text{C}$	82		
			$T_{vj} = 175^\circ\text{C}$	86		

(table continues...)

Table 5 (continued) Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Fall time (inductive load)	t_f	$I_D = 200 \text{ A}$, $R_{Goff} = 1 \Omega$, $V_{DD} = 600 \text{ V}$, $V_{GS} = -3/18 \text{ V}$	$T_{vj} = 25 \text{ }^\circ\text{C}$		16	ns
			$T_{vj} = 125 \text{ }^\circ\text{C}$		16	
			$T_{vj} = 175 \text{ }^\circ\text{C}$		16	
Turn-on energy loss per pulse	E_{on}	$I_D = 200 \text{ A}$, $V_{DD} = 600 \text{ V}$, $L_\sigma = 7 \text{ nH}$, $V_{GS} = -3/18 \text{ V}$, $R_{Gon} = 2.7 \Omega$, $di/dt = 8.8 \text{ kA}/\mu\text{s}$ ($T_{vj} = 175 \text{ }^\circ\text{C}$)	$T_{vj} = 25 \text{ }^\circ\text{C}$		3.22	mJ
			$T_{vj} = 125 \text{ }^\circ\text{C}$		3.77	
			$T_{vj} = 175 \text{ }^\circ\text{C}$		4.29	
Turn-off energy loss per pulse	E_{off}	$I_D = 200 \text{ A}$, $V_{DD} = 600 \text{ V}$, $L_\sigma = 7 \text{ nH}$, $V_{GS} = -3/18 \text{ V}$, $R_{Goff} = 1 \Omega$, $dv/dt = 30 \text{ kV}/\mu\text{s}$ ($T_{vj} = 175 \text{ }^\circ\text{C}$)	$T_{vj} = 25 \text{ }^\circ\text{C}$		0.84	mJ
			$T_{vj} = 125 \text{ }^\circ\text{C}$		0.85	
			$T_{vj} = 175 \text{ }^\circ\text{C}$		0.86	
SC data	I_{SC}	$V_{GS} = -5/15 \text{ V}$, $V_{DD} = 800 \text{ V}$, $V_{DSmax} = V_{DSS} - L_{sDS} * di/dt$, $R_G = 10 \Omega$	$t_p = 2 \mu\text{s}$, $T_{vj} = 25 \text{ }^\circ\text{C}$		1680	A
			$t_p = 2 \mu\text{s}$, $T_{vj} = 150 \text{ }^\circ\text{C}$		1640	
Thermal resistance, junction to heat sink	R_{thJH}	per MOSFET, $\lambda_{grease} = 1 \text{ W}/(\text{m}\cdot\text{K})$			0.328	K/W
Temperature under switching conditions	$T_{vj op}$			-40	175	°C

Note: The selection of positive and negative gate-source voltages impacts losses and the long-term behavior of the MOSFET and body diode. The design guidelines described in Application Notes AN 2018-09 and AN 2021-13 must be considered to ensure sound operation of the device over the planned lifetime.
 $T_{vj,op} > 150^\circ\text{C}$ is allowed for operation at overload conditions for MOSFET and body diode. For detailed specifications, please refer to AN 2021-13.

3 Body diode (MOSFET)

Table 6 Maximum rated values

Parameter	Symbol	Note or test condition		Values	Unit
DC body diode forward current	I_{SD}	$T_{vj} = 175 \text{ }^\circ\text{C}$, $V_{GS} = -3 \text{ V}$	$T_H = 65 \text{ }^\circ\text{C}$	85	A

Table 7 Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Forward voltage	V_{SD}	$I_{SD} = 200 \text{ A}, V_{GS} = -3 \text{ V}$	$T_{vj} = 25 \text{ }^{\circ}\text{C}$		4.2	5.35
			$T_{vj} = 125 \text{ }^{\circ}\text{C}$		3.9	
			$T_{vj} = 175 \text{ }^{\circ}\text{C}$		3.8	

4 NTC-Thermistor

Table 8 Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Rated resistance	R_{25}	$T_{NTC} = 25 \text{ }^{\circ}\text{C}$		5		$\text{k}\Omega$
Deviation of R_{100}	$\Delta R/R$	$T_{NTC} = 100 \text{ }^{\circ}\text{C}, R_{100} = 493 \Omega$	-5		5	%
Power dissipation	P_{25}	$T_{NTC} = 25 \text{ }^{\circ}\text{C}$			20	mW
B-value	$B_{25/50}$	$R_2 = R_{25} \exp[B_{25/50}(1/T_2 - 1/(298,15 \text{ K}))]$		3375		K
B-value	$B_{25/80}$	$R_2 = R_{25} \exp[B_{25/80}(1/T_2 - 1/(298,15 \text{ K}))]$		3411		K
B-value	$B_{25/100}$	$R_2 = R_{25} \exp[B_{25/100}(1/T_2 - 1/(298,15 \text{ K}))]$		3433		K

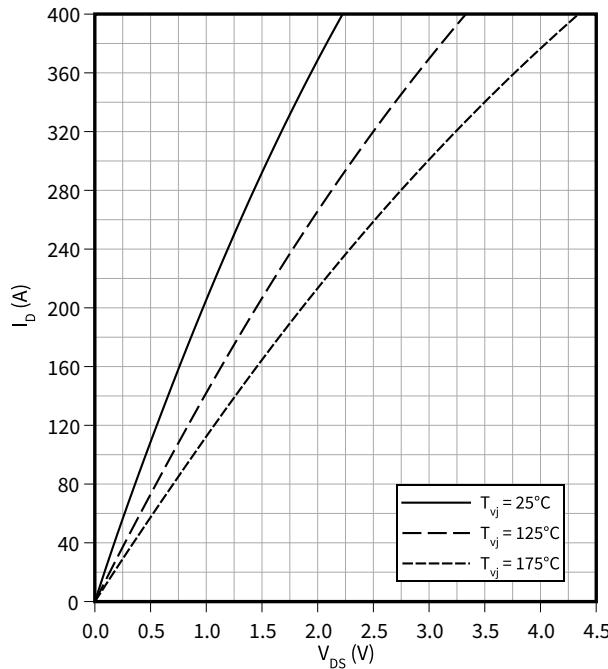
Note: Specification according to the valid application note.

5 Characteristics diagrams

Output characteristic (typical), MOSFET

$$I_D = f(V_{DS})$$

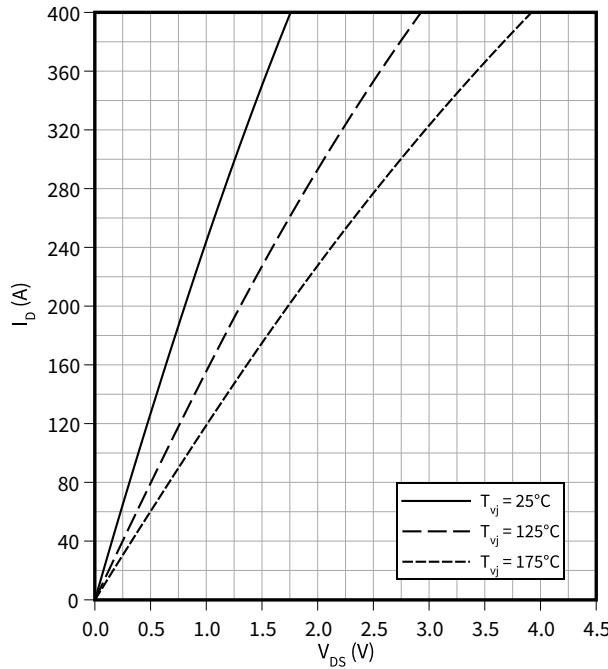
$$V_{GS} = 15 \text{ V}$$



Output characteristic (typical), MOSFET

$$I_D = f(V_{DS})$$

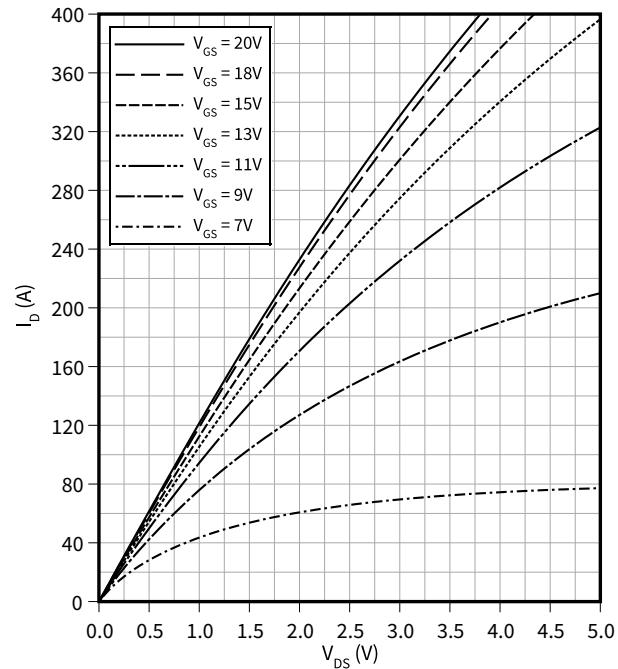
$$V_{GS} = 18 \text{ V}$$



Output characteristic field(typical), MOSFET

$$I_D = f(V_{DS})$$

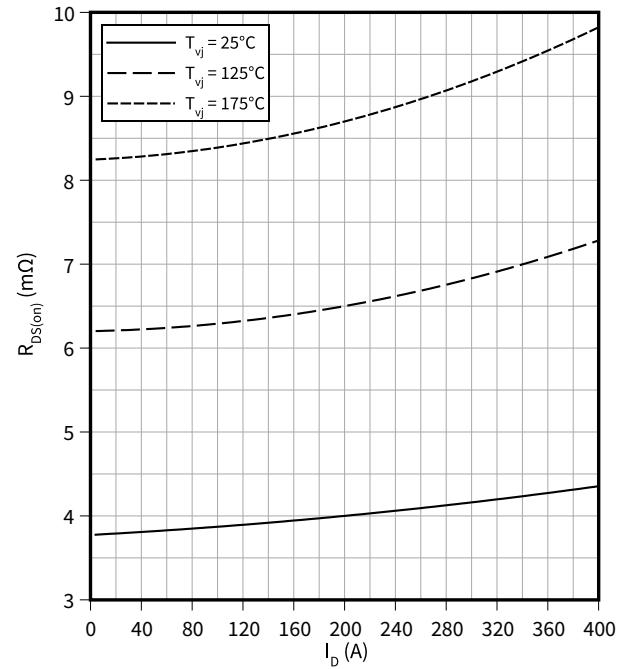
$$T_{vj} = 175^\circ\text{C}$$



Drain source on-resistance (typical), MOSFET

$$R_{DS(on)} = f(I_D)$$

$$V_{GS} = 18 \text{ V}$$

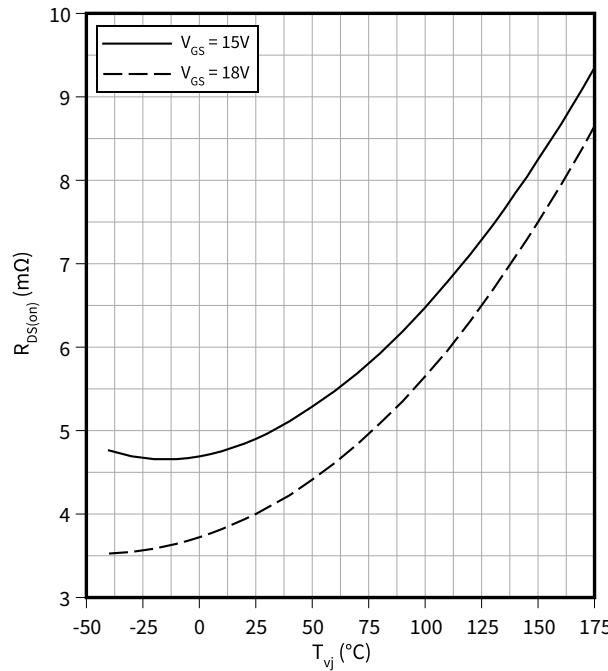


5 Characteristics diagrams

Drain source on-resistance (typical), MOSFET

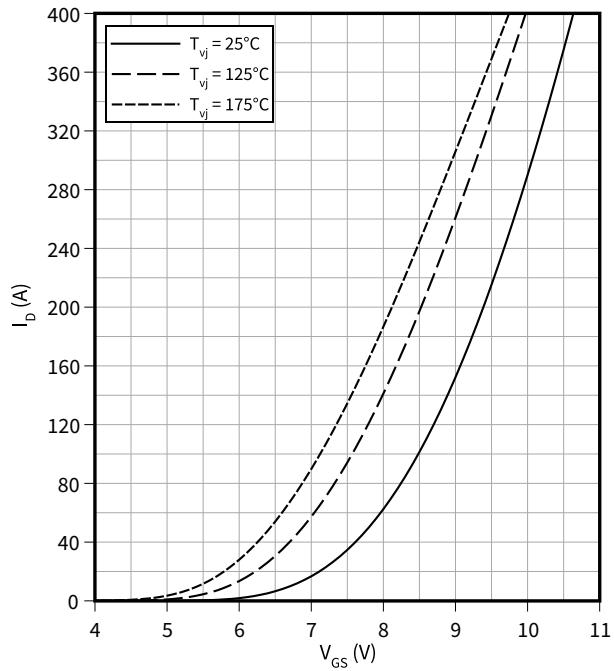
$$R_{DS(on)} = f(T_{vj})$$

$$I_D = 200 \text{ A}$$

**Transfer characteristic (typical), MOSFET**

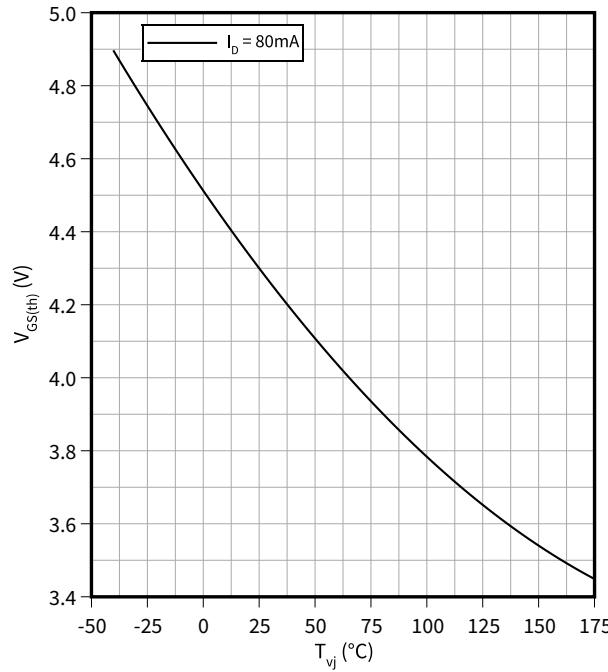
$$I_D = f(V_{GS})$$

$$V_{DS} = 20 \text{ V}$$

**Gate-source threshold voltage (typical), MOSFET**

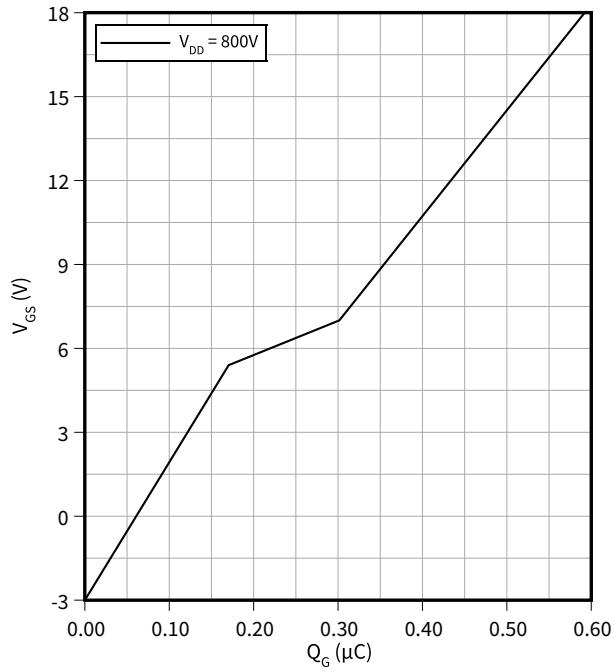
$$V_{GS(th)} = f(T_{vj})$$

$$V_{GS} = V_{DS}$$

**Gate charge characteristic (typical), MOSFET**

$$V_{GS} = f(Q_G)$$

$$I_D = 200 \text{ A}, T_{vj} = 25 \text{ °C}$$

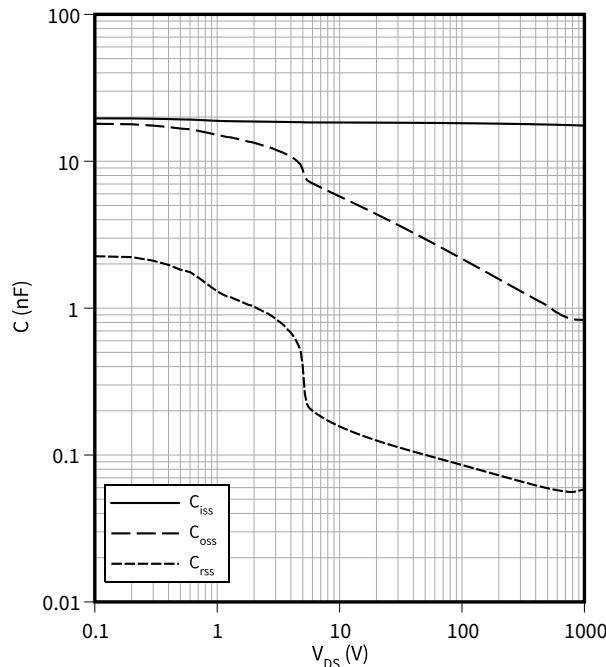


5 Characteristics diagrams

Capacity characteristic (typical), MOSFET

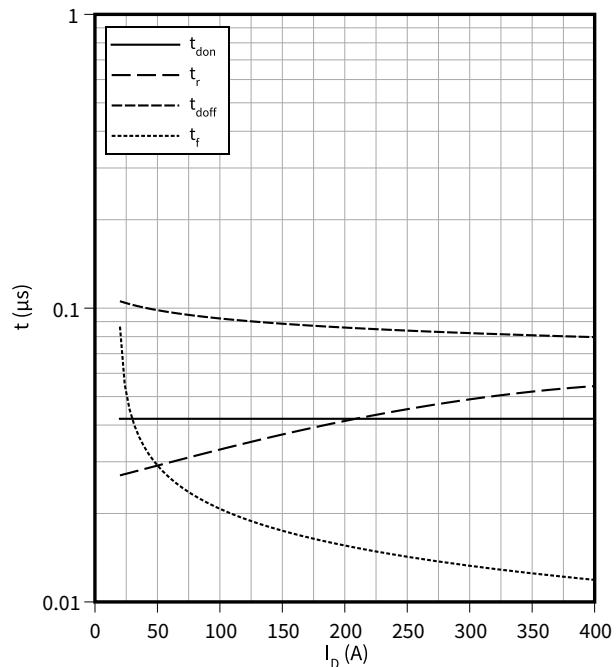
$$C = f(V_{DS})$$

$f = 100 \text{ kHz}$, $T_{vj} = 25^\circ\text{C}$, $V_{GS} = 0 \text{ V}$

**Switching times (typical), MOSFET**

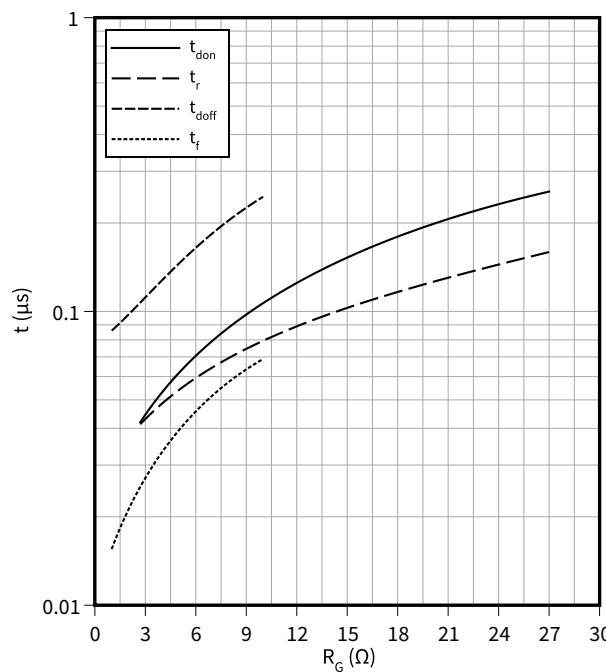
$$t = f(I_D)$$

$R_{Goff} = 1 \Omega$, $R_{Gon} = 2.7 \Omega$, $V_{DD} = 600 \text{ V}$, $T_{vj} = 175^\circ\text{C}$, $V_{GS} = -3/18 \text{ V}$

**Switching times (typical), MOSFET**

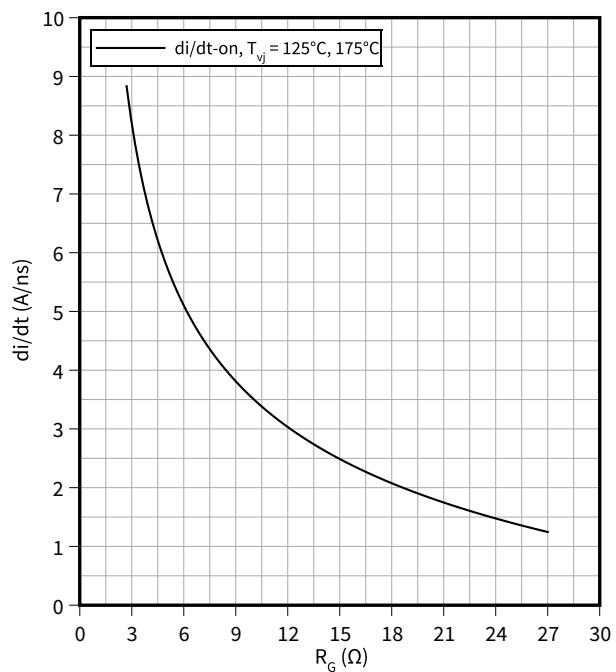
$$t = f(R_G)$$

$V_{DD} = 600 \text{ V}$, $I_D = 200 \text{ A}$, $T_{vj} = 175^\circ\text{C}$, $V_{GS} = -3/18 \text{ V}$

**Current slope (typical), MOSFET**

$$di/dt = f(R_G)$$

$V_{DD} = 600 \text{ V}$, $I_D = 200 \text{ A}$, $V_{GS} = -3/18 \text{ V}$

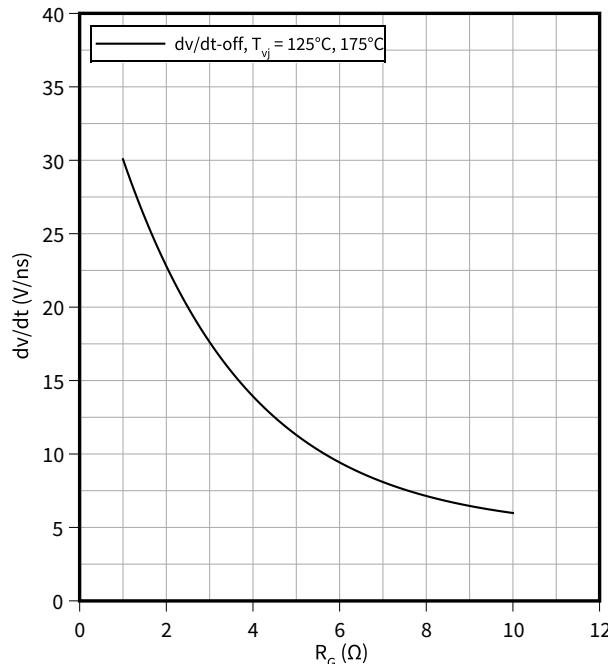


5 Characteristics diagrams

Voltage slope (typical), MOSFET

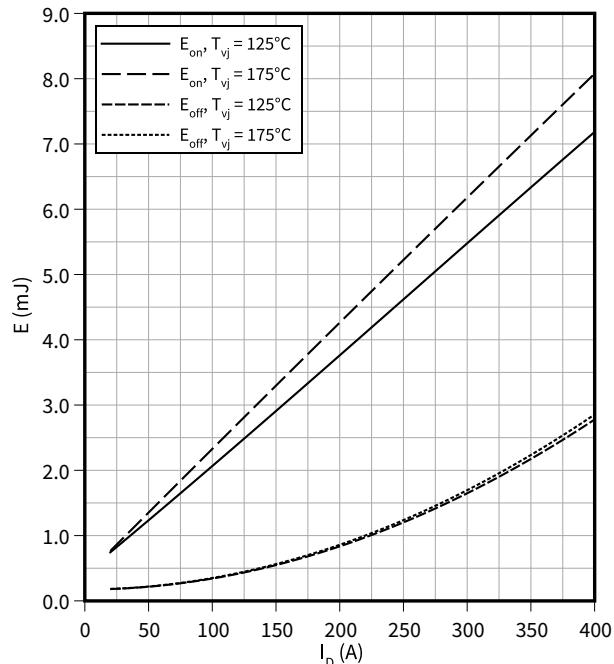
$$dv/dt = f(R_G)$$

$$V_{DD} = 600 \text{ V}, I_D = 200 \text{ A}, V_{GS} = -3/18 \text{ V}$$

**Switching losses (typical), MOSFET**

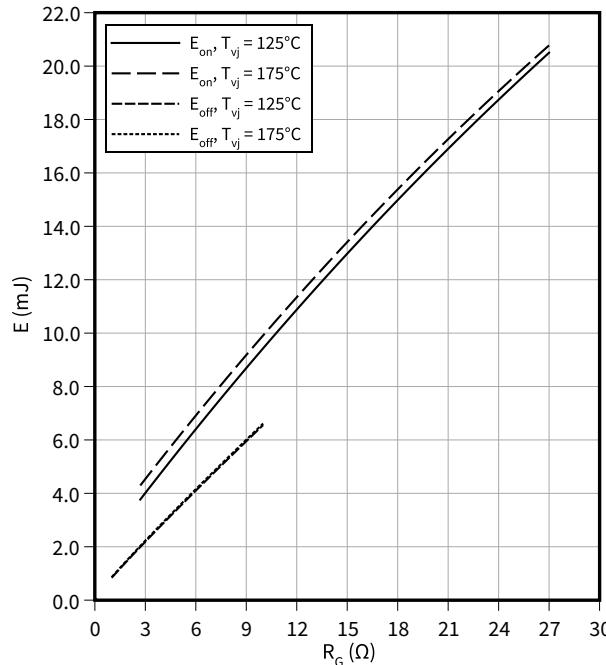
$$E = f(I_D)$$

$$R_{Goff} = 1 \Omega, R_{Gon} = 2.7 \Omega, V_{DD} = 600 \text{ V}, V_{GS} = -3/18 \text{ V}$$

**Switching losses (typical), MOSFET**

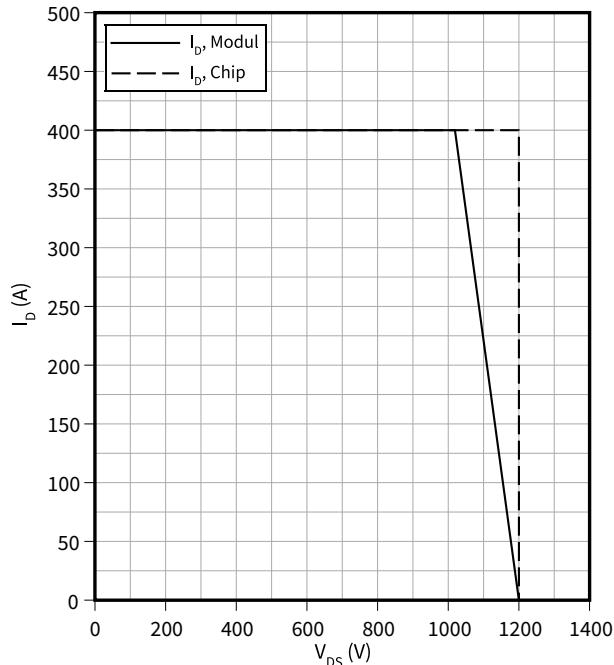
$$E = f(R_G)$$

$$V_{DD} = 600 \text{ V}, I_D = 200 \text{ A}, V_{GS} = -3/18 \text{ V}$$

**Reverse bias safe operating area (RBSOA), MOSFET**

$$I_D = f(V_{DS})$$

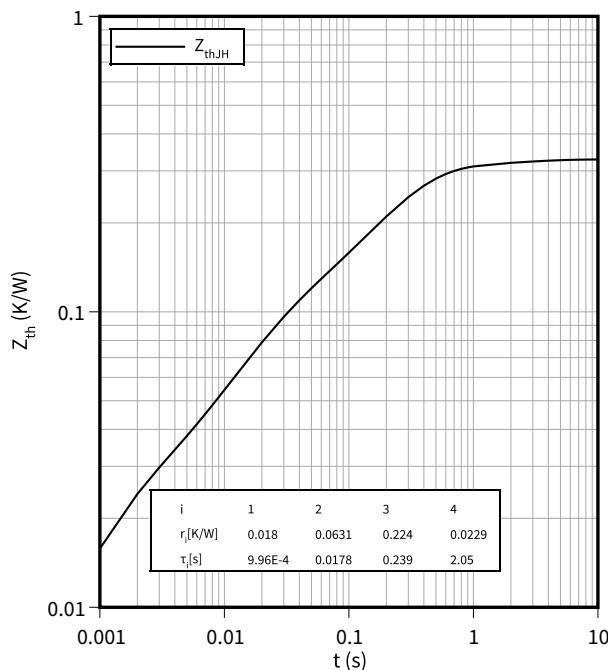
$$R_{Goff} = 1 \Omega, T_{vj} = 175^\circ\text{C}, V_{GS} = -3/18 \text{ V}$$



5 Characteristics diagrams

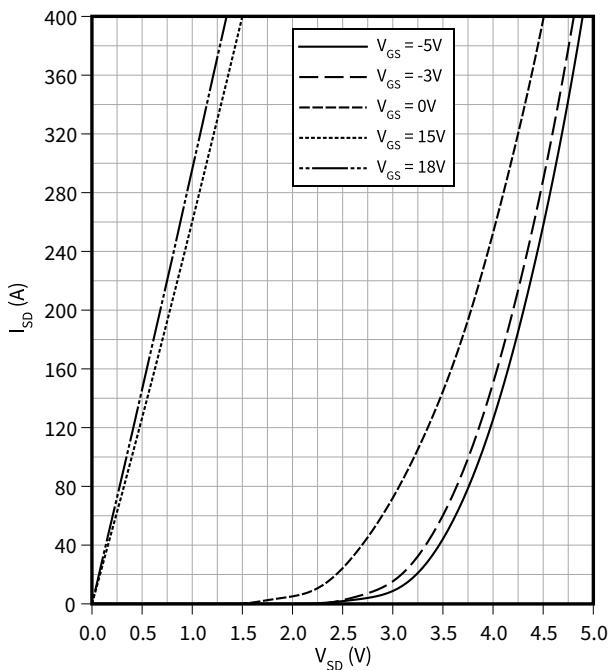
Transient thermal impedance , MOSFET

$$Z_{th} = f(t)$$

**Forward characteristic body diode (typical), MOSFET**

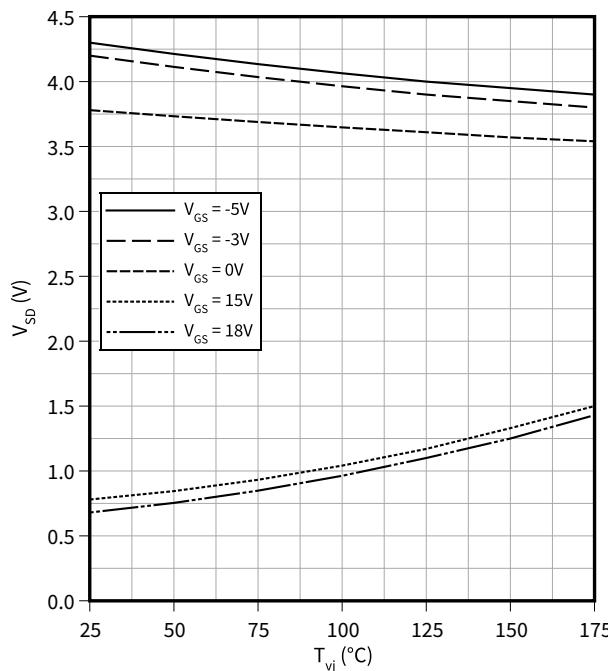
$$I_{SD} = f(V_{SD})$$

$$T_{vj} = 25^\circ\text{C}$$

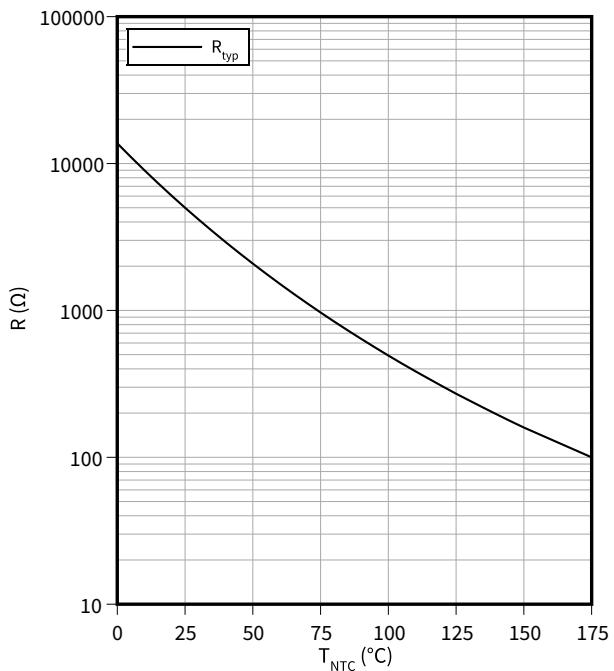
**Forward voltage of body diode (typical), MOSFET**

$$V_{SD} = f(T_{vj})$$

$$I_{SD} = 200 \text{ A}$$

**Temperature characteristic (typical), NTC-Thermistor**

$$R = f(T_{NTC})$$



6 Circuit diagram

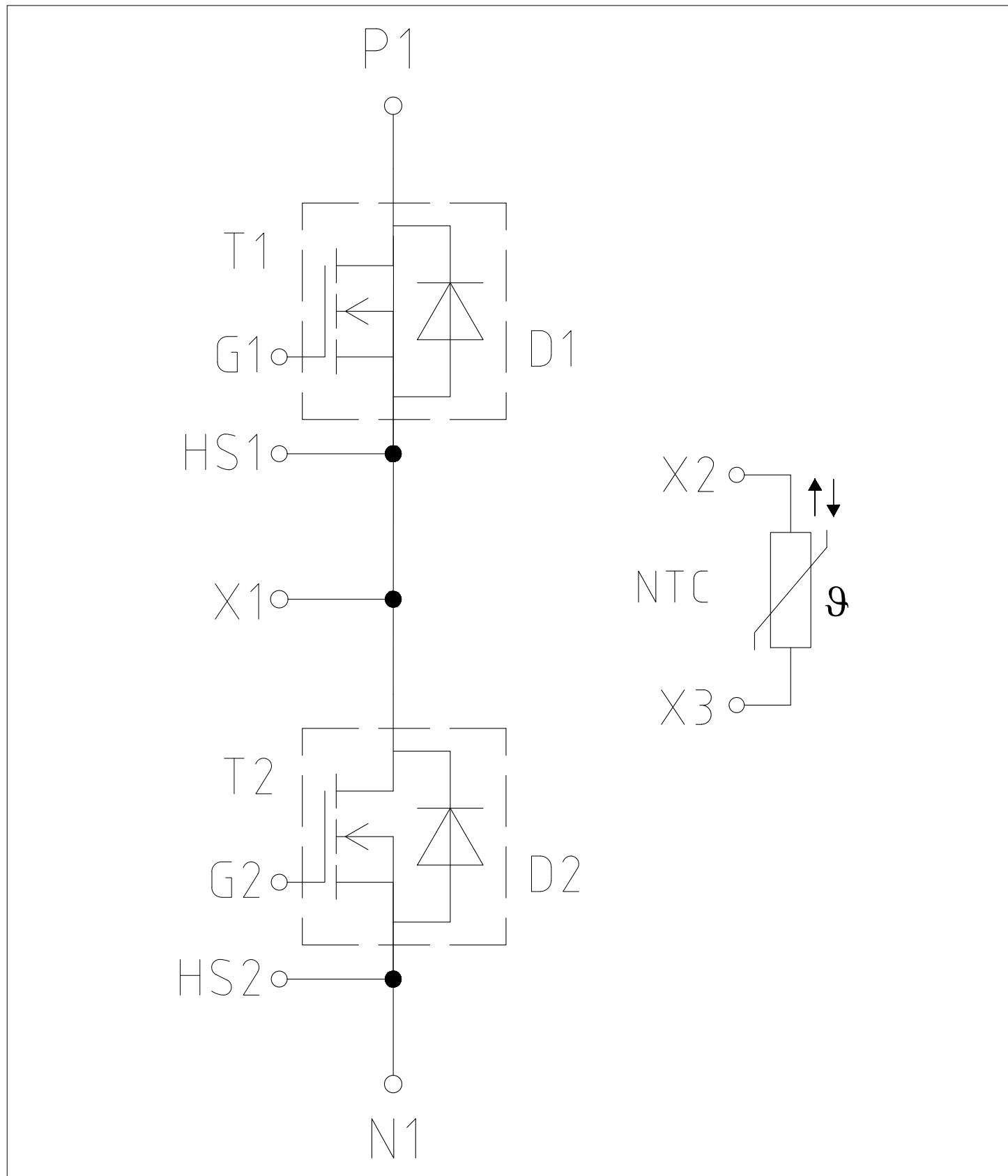
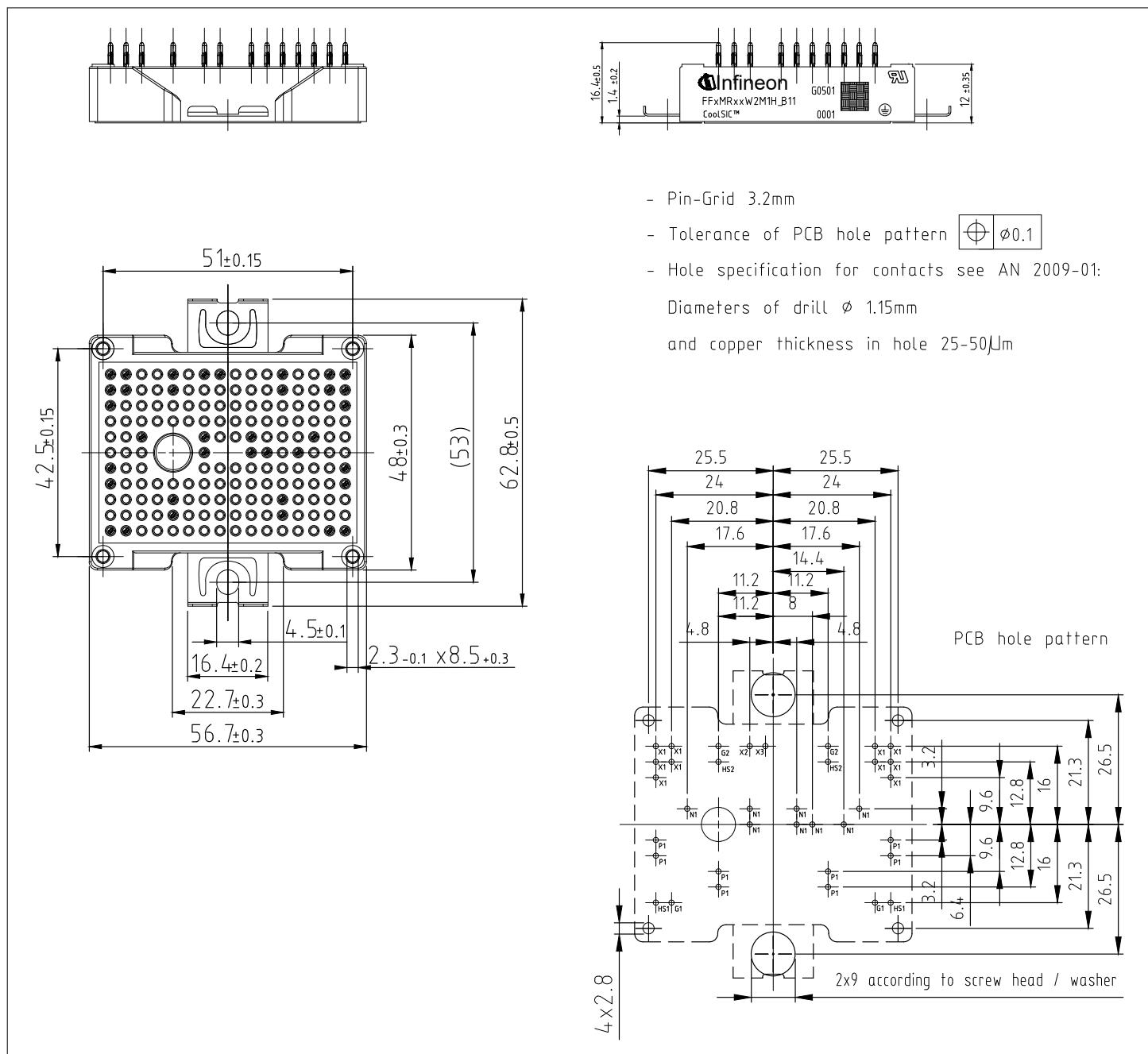


Figure 1

7 Package outlines

**Figure 2**

8 Module label code

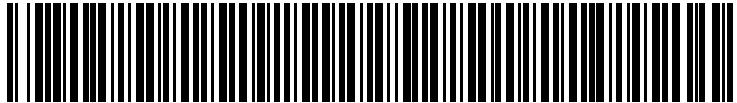
Module label code			
Code format	Data Matrix		Barcode Code128
Encoding	ASCII text		Code Set A
Symbol size	16x16		23 digits
Standard	IEC24720 and IEC16022		IEC8859-1
Code content	<p><i>Content</i></p> <p>Module serial number Module material number Production order number Date code (production year) Date code (production week)</p>	<p><i>Digit</i></p> <p>1 – 5 6 - 11 12 - 19 20 – 21 22 – 23</p>	<p><i>Example</i></p> <p>71549 142846 55054991 15 30</p>
Example			71549142846550549911530

Figure 3